

<b>Notice of References Cited</b>	Application/Control No. 09/814,425	Applicant(s)/Patent Under <del>Reexamination</del> WANG ET AL.	
	Examiner Michael P. Mooney	Art Unit 2883	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,615,614	09-2003	Makikawa et al.	65/386
	B	US-5,263,111	11-1993	Nurse et al.	385/130
	C	US-5,410,622	04-1995	Okada et al.	385/14
	D	US-5,770,465	06-1998	MacDonald et al.	216/2
	E	US-6,355,184	03-2002	Crevasse et al.	216/93
	F	US-5,408,569	04-1995	Nishimoto, Hiroshi	385/132
	G	US-6,768,856	07-2004	Akwani et al.	385/129
	H	US-6,434,282	08-2002	Binkley et al.	385/8
	I	US-6,506,289	01-2003	Demaray et al.	204/192.26
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	09080246	03-1997	Japan	Shinobu	G02B 6/13
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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